

<b>Notice of References Cited</b>	Application/Control No. 10/786,475	Applicant(s)/Patent Under Reexamination KONVICKA, KAREL	
	Examiner Russell S. Negin	Art Unit 1631	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0017487	01-2003	Xue et al.	435/6
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	D	US-			
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	J	US-			
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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.